## nexperia

## **Reliability Monitoring Results**

## Quarters: Q1/2022 to Q4/2022

Based on structural similarity

| Suppl         | ier  | User Part Number  |                             |           |            |              |  |  |
|---------------|--|---|-----------------------------|-----------|------------|--------------|--|--|
| Nexperia B.V. |  | 74LVT640D   |                             |           |            |              |  |  |
| Part D        | Description: Octal transceive                                      | er with bus hold; inverting (                                     | (3-state)                   |           |            |              |  |  |
| Pro           | nction Family: LVT<br>ocess family: Sub micron<br>ckage family: SO |   |                             |           |            |              |  |  |
| JESD4         | 17 Test  | Test Conditions   | Duration                    | # Lots    | # Quantity | #<br>Rejects |  |  |
|               | TEST   |   |                             |           |            | see          |  |  |
| #1            | Pre- and Post-Stress<br>Electrical Test                            | Tamb = 25 °C  | N/A                         | see below | all parts  | below        |  |  |
| # 2           | <b>PC</b><br>Preconditioning                                       | JESD22-A113<br>MSL 1  | N/A                         | 460       | 29380      | 0            |  |  |
| # 5a          | HTOL EFR<br>High Temperature<br>Operating Life Extrinsic           | JESD22-A108<br>Tj = 150°C<br>$V_{CCMAX} \le V \le 1.2*V_{CCMAX}$  | 48 hours<br>or<br>168 hours | 132       | 33268      | 0            |  |  |
| # 5b          | HTOL IFR<br>High Temperature<br>Operating Life Intrinsic           | JESD22-A108<br>Tj = 150°C<br>$V_{CCMAX} \le V \le 1.2*V_{CCMAX}$  | ≥500 hours                  | 89        | 7065       | 0            |  |  |
| # 7           | TC<br>Temperature Cycling  | JESD22-A104<br>-65 °C to 150°C                                    | ≥500 cycles                 | 69        | 17630      | 4            |  |  |
| # 9           | uHAST / HAST<br>unbiased or biased High<br>Accelerated Stress Test | JESD22-A101<br>Tamb = 130 °C,<br>RH = 85%, V = V <sub>CCMAX</sub> | 96 hours                    | 202       | 11750      | 0            |  |  |

## Calculation of PPM, FIT and MTTF

Test considered for PPM calculation: High Temperature Operating LifeTest Extrinsic (HTOL EFR, Test # 5a above) Test considered for FIT and MTTF calculations: High Temperature Operating LifeTest Intrinsic(HTOL IFR, Test # 5b above)

Confidence level 60%, derated to 55 °C, activation energy 0.7 eV, test time 168 to 1000 hours

| Product<br>Family | Package<br>Family | Quantity | Rejects | Extrinsic<br>Failure Rate (PPM) | Intrinsic<br>Failure Rate (FIT) | MTTF (hrs) |
|-------------------|-------------------|----------|---------|---------------------------------|---------------------------------|------------|
| LVT               | SO                | 7065     | 0       | 28                              | 0.5                             | 2.07 E+09  |

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